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Embedded - Microcontrollers - Application Specific: Tailored Solutions for Precision and Performance

Embedded - Microcontrollers - Application Specific represents a category of microcontrollers designed with unique features and capabilities tailored to specific application needs. Unlike general-purpose microcontrollers, application-specific microcontrollers are optimized for particular tasks, offering enhanced performance, efficiency, and functionality to meet the demands of specialized applications.

What Are Embedded - Microcontrollers - Application Specific?

Application specific microcontrollers are engineered to

Details

Product Status	Obsolete
Applications	Capacitive Sensing
Core Processor	M8C
Program Memory Type	FLASH (16kB)
Controller Series	CY8C20xx6A
RAM Size	2K x 8
Interface	I ² C, SPI, USB
Number of I/O	36
Voltage - Supply	1.71V ~ 5.5V
Operating Temperature	-40°C ~ 85°C
Mounting Type	Surface Mount
Package / Case	48-UFQFN Exposed Pad
Supplier Device Package	48-QFN (6x6)
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/cy8c20646as-24lqxit

More Information

Cypress provides a wealth of data at www.cypress.com to help you to select the right PSoC device for your design, and to help you to quickly and effectively integrate the device into your design. For a comprehensive list of resources, see the knowledge base article [KBA92181, Resources Available for CapSense® Controllers](#). Following is an abbreviated list for CapSense devices:

- Overview: [CapSense Portfolio](#), [CapSense Roadmap](#)
- Product Selectors: [CapSense](#), [CapSense Plus](#), [CapSense Express](#), [PSoC3 with CapSense](#), [PSoC5 with CapSense](#), [PSoC4](#). In addition, [PSoC Designer](#) offers a device selection tool at the time of creating a new project.
- Application notes: Cypress offers CapSense application notes covering a broad range of topics, from basic to advanced level. Recommended application notes for getting started with CapSense are:
 - [AN64846: Getting Started With CapSense](#)
 - [AN73034: CY8C20xx6A/H/AS CapSense® Design Guide](#)
 - [AN2397: CapSense® Data Viewing Tools](#)
- Technical Reference Manual (TRM):
 - [PSoC® CY8C20xx6A/AS/L Family Technical Reference Manual](#)

- Development Kits:
 - [CY3280-20x66 Universal CapSense Controller Kit](#) features a predefined control circuitry and plug-in hardware to make prototyping and debugging easy. Programming and I2C-to-USB Bridge hardware are included for tuning and data acquisition.
 - [CY3280-BMM Matrix Button Module Kit](#) consists of eight CapSense sensors organized in a 4x4 matrix format to form 16 physical buttons and eight LEDs. This module connects to any CY3280 Universal CapSense Controller Board, including CY3280-20x66 Universal CapSense Controller.
 - [CY3280-BSM Simple Button Module Kit](#) consists of ten CapSense buttons and ten LEDs. This module connects to any CY3280 Universal CapSense Controller Board, including CY3280-20x66 Universal CapSense Controller.

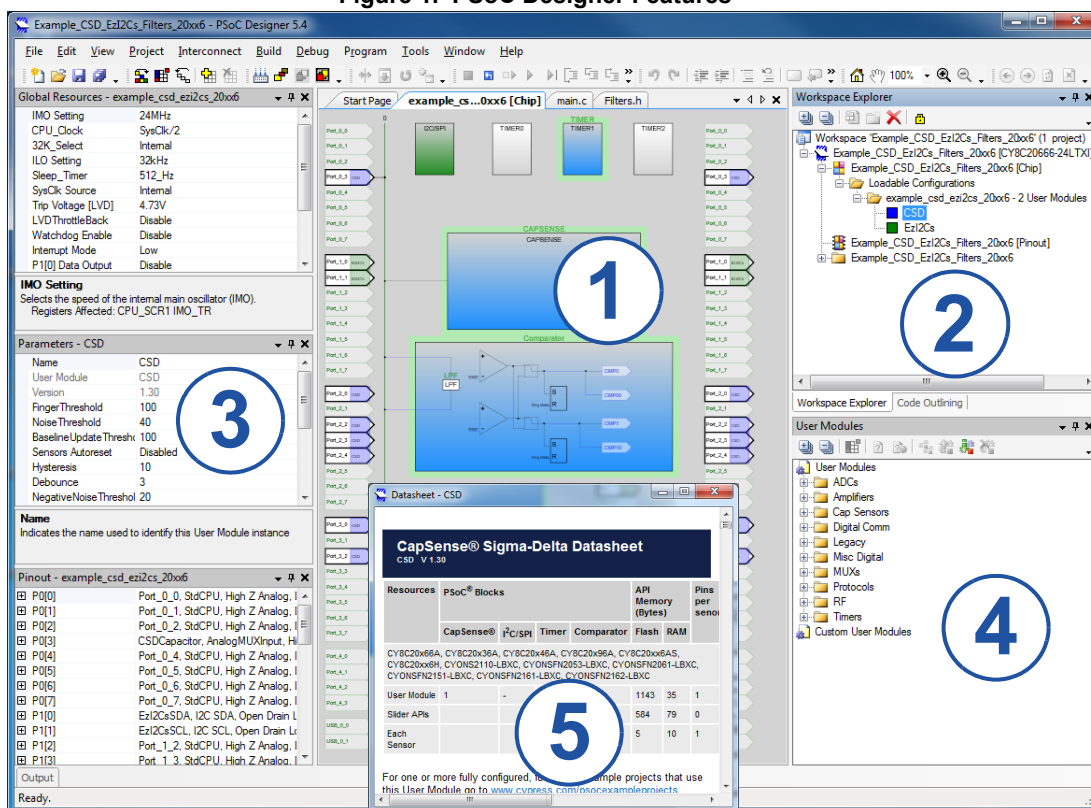
The [CY3217-MiniProg1](#) and [CY8CKIT-002 PSoC® MiniProg3](#) device provides an interface for flash programming.

PSoC Designer

[PSoC Designer](#) is a free Windows-based Integrated Design Environment (IDE). It enables concurrent hardware and firmware design of systems based on CapSense (see [Figure 1](#)). With PSoC Designer, you can:

1. Drag and drop User Modules to build your hardware system design in the main design workspace
2. Codesign your application firmware with the PSoC hardware, using the PSoC Designer IDE C compiler
3. Configure User Module
4. Explore the library of user modules
5. Review user module datasheets

Figure 1. PSoC Designer Features



Getting Started

The quickest way to understand PSoC silicon is to read this datasheet and then use the PSoC Designer Integrated Development Environment (IDE). This datasheet is an overview of the PSoC integrated circuit and presents specific pin, register, and electrical specifications.

For in depth information, along with detailed programming details, see the [Technical Reference Manual](#) for the CY8C20XX6A/S PSoC devices.

For up-to-date ordering, packaging, and electrical specification information, see the latest PSoC device datasheets on the web at www.cypress.com/psoc.

CapSense Design Guides

Design Guides are an excellent introduction to the wide variety of possible CapSense designs. They are located at www.cypress.com/go/CapSenseDesignGuides.

Refer Getting Started with CapSense design guide for information on CapSense design and CY8C20XX6A/H/AS CapSense® Design Guide for specific information on CY8C20XX6A/AS CapSense controllers.

Silicon Errata

Errata documents known issues with silicon including errata trigger conditions, scope of impact, available workarounds and silicon revision applicability. Refer to Silicon Errata for the PSoC® CY8C20x36A/46A/66A/96A/46AS/66AS/36H/46H families available at <http://www.cypress.com/?rID=56239> for errata information on CY8C20xx6A/AS/H family of device. Compare errata document with datasheet for a complete functional description of device.

Development Kits

[PSoC Development Kits](#) are available online from and through a growing number of regional and global distributors, which include Arrow, Avnet, Digi-Key, Farnell, Future Electronics, and Newark.

Training

[Free PSoC technical training](#) (on demand, webinars, and workshops), which is available online via www.cypress.com, covers a wide variety of topics and skill levels to assist you in your designs.

CYPros Consultants

Certified PSoC consultants offer everything from technical assistance to completed PSoC designs. To contact or become a PSoC consultant go to the [CYPros Consultants](#) web site.

Solutions Library

Visit our growing [library of solution focused designs](#). Here you can find various application designs that include firmware and hardware design files that enable you to complete your designs quickly.

Technical Support

[Technical support](#) – including a searchable Knowledge Base articles and technical forums – is also available online. If you cannot find an answer to your question, call our Technical Support hotline at 1-800-541-4736.

Development Tools

PSoC Designer™ is the revolutionary integrated design environment (IDE) that you can use to customize PSoC to meet your specific application requirements. PSoC Designer software accelerates system design and time to market. Develop your applications using a library of precharacterized analog and digital peripherals (called user modules) in a drag-and-drop design environment. Then, customize your design by leveraging the dynamically generated application programming interface (API) libraries of code. Finally, debug and test your designs with the integrated debug environment, including in-circuit emulation and standard software debug features. PSoC Designer includes:

- Application editor graphical user interface (GUI) for device and user module configuration and dynamic reconfiguration
- Extensive user module catalog
- Integrated source-code editor (C and assembly)
- Free C compiler with no size restrictions or time limits
- Built-in debugger
- In-circuit emulation
- Built-in support for communication interfaces:
 - Hardware and software I²C slaves and masters
 - Full-speed USB 2.0
 - Up to four full-duplex universal asynchronous receiver/transmitters (UARTs), SPI master and slave, and wireless

PSoC Designer supports the entire library of PSoC 1 devices and runs on Windows XP, Windows Vista, and Windows 7.

PSoC Designer Software Subsystems

Design Entry

In the chip-level view, choose a base device to work with. Then select different onboard analog and digital components that use the PSoC blocks, which are called user modules. Examples of user modules are analog-to-digital converters (ADCs), digital-to-analog converters (DACs), amplifiers, and filters. Configure the user modules for your chosen application and connect them to each other and to the proper pins. Then generate your project. This prepopulates your project with APIs and libraries that you can use to program your application.

The tool also supports easy development of multiple configurations and dynamic reconfiguration. Dynamic reconfiguration makes it possible to change configurations at run time. In essence, this lets you to use more than 100 percent of PSoC's resources for an application.

Code Generation Tools

The code generation tools work seamlessly within the PSoC Designer interface and have been tested with a full range of debugging tools. You can develop your design in C, assembly, or a combination of the two.

Assemblers. The assemblers allow you to merge assembly code seamlessly with C code. Link libraries automatically use absolute addressing or are compiled in relative mode, and linked with other software modules to get absolute addressing.

C Language Compilers. C language compilers are available that support the PSoC family of devices. The products allow you to create complete C programs for the PSoC family devices. The optimizing C compilers provide all of the features of C, tailored to the PSoC architecture. They come complete with embedded libraries providing port and bus operations, standard keypad and display support, and extended math functionality.

Debugger

PSoC Designer has a debug environment that provides hardware in-circuit emulation, allowing you to test the program in a physical system while providing an internal view of the PSoC device. Debugger commands allow you to read and program and read and write data memory, and read and write I/O registers. You can read and write CPU registers, set and clear breakpoints, and provide program run, halt, and step control. The debugger also lets you to create a trace buffer of registers and memory locations of interest.

Online Help System

The online help system displays online, context-sensitive help. Designed for procedural and quick reference, each functional subsystem has its own context-sensitive help. This system also provides tutorials and links to FAQs and an Online Support Forum to aid the designer.

In-Circuit Emulator

A low-cost, high-functionality in-circuit emulator (ICE) is available for development support. This hardware can program single devices.

The emulator consists of a base unit that connects to the PC using a USB port. The base unit is universal and operates with all PSoC devices. Emulation pods for each device family are available separately. The emulation pod takes the place of the PSoC device in the target board and performs full-speed (24 MHz) operation.

32-pin QFN (25 Sensing Inputs) [22]

Table 5. Pin Definitions – CY8C20436A, CY8C20446A, CY8C20446AS, CY8C20466A, CY8C20466AS[23]

Pin No.	Type		Name	Description
	Digital	Analog		
1	IOH	I	P0[1]	Integrating input
2	I/O	I	P2[7]	
3	I/O	I	P2[5]	Crystal output (XOut)
4	I/O	I	P2[3]	Crystal input (XIn)
5	I/O	I	P2[1]	
6	I/O	I	P3[3]	
7	I/O	I	P3[1]	
8	IOHR	I	P1[7]	I ² C SCL, SPI SS
9	IOHR	I	P1[5]	I ² C SDA, SPI MISO
10	IOHR	I	P1[3]	SPI CLK.
11	IOHR	I	P1[1]	ISSP CLK ^[24] , I ² C SCL, SPI MOSI.
12	Power		V _{SS}	Ground connection ^[26]
13	IOHR	I	P1[0]	ISSP DATA ^[24] , I ² C SDA, SPI CLK ^[25]
14	IOHR	I	P1[2]	
15	IOHR	I	P1[4]	Optional external clock input (EXTCLK)
16	IOHR	I	P1[6]	
17	Input		XRES	Active high external reset with internal pull-down
18	I/O	I	P3[0]	
19	I/O	I	P3[2]	
20	I/O	I	P2[0]	
21	I/O	I	P2[2]	
22	I/O	I	P2[4]	
23	I/O	I	P2[6]	
24	IOH	I	P0[0]	
25	IOH	I	P0[2]	
26	IOH	I	P0[4]	
27	IOH	I	P0[6]	
28	Power		V _{DD}	Supply voltage
29	IOH	I	P0[7]	
30	IOH	I	P0[5]	
31	IOH	I	P0[3]	Integrating input
32	Power		V _{SS}	Ground connection ^[26]
CP	Power		V _{SS}	Center pad must be connected to ground

LEGEND A = Analog, I = Input, O = Output, OH = 5 mA High Output Drive, R = Regulated Output.

Notes

22. 28 GPIOs = 25 pins for capacitive sensing + 2 pins for I2C + 1 pin for modulation capacitor.

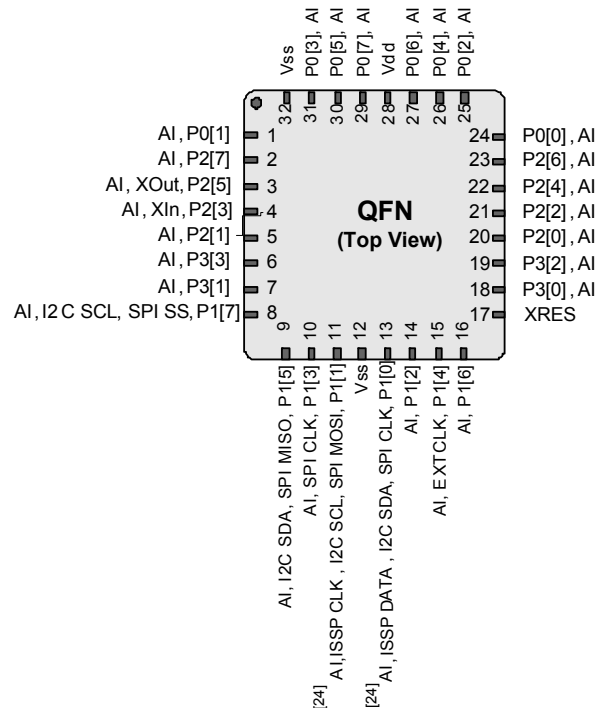
23. The center pad (CP) on the QFN package must be connected to ground (V_{SS}) for best mechanical, thermal, and electrical performance. If not connected to ground, it must be electrically floated and not connected to any other signal.

24. On power-up, the SDA(P1[0]) drives a strong high for 256 sleep clock cycles and drives resistive low for the next 256 sleep clock cycles. The SCL(P1[1]) line drives resistive low for 512 sleep clock cycles and both the pins transition to high impedance state. On reset, after XRES de-asserts, the SDA and the SCL lines drive resistive low for 8 sleep clock cycles and transition to high impedance state. Hence, during power-up or reset event, P1[1] and P1[0] may disturb the I2C bus. Use alternate pins if you encounter issues.

25. Alternate SPI clock.

26. All VSS pins should be brought out to one common GND plane.

Figure 7. CY8C20436A, CY8C20446A, CY8C20446AS, CY8C20466A, CY8C20466AS



32-pin QFN (22 Sensing Inputs (With USB)) ^[27]

Table 6. Pin Definitions – CY8C20496A^[28]

Pin No.	Type		Name	Description
	Digital	Analog		
1	IOH	I	P0[1]	Integrating Input
2	I/O	I	P2[5]	XTAL Out
3	I/O	I	P2[3]	XTAL In
4	I/O	I	P2[1]	
5	IOHR	I	P1[7]	I ² C SCL, SPI SS
6	IOHR	I	P1[5]	I ² C SDA, SPI MISO
7	IOHR	I	P1[3]	SPI CLK
8	IOHR	I	P1[1]	ISSP CLK ^[29] , I ² C SCL, SPI MOSI
9	Power		V _{SS}	Ground Pin ^[31]
10	I		D+	USB D+
11			D-	USB D-
12	Power		V _{DD}	Power pin
13	IOHR	I	P1[0]	ISSP DATA ^[29] , I ² C SDA, SPI CLK ^[30]
14	IOHR	I	P1[2]	
15	IOHR	I	P1[4]	Optional external clock input (EXTCLK)
16	IOHR	I	P1[6]	
17	Input		XRES	Active high external reset with internal pull-down
18	I/O	I	P3[0]	
19	I/O	I	P3[2]	
20	I/O	I	P2[0]	
21	I/O	I	P2[2]	
22	I/O	I	P2[4]	
23	I/O	I	P2[6]	
24	IOH	I	P0[0]	
25	IOH	I	P0[2]	
26	IOH	I	P0[4]	
27	IOH	I	P0[6]	
28	Power		V _{DD}	Power Pin
29	IOH	I	P0[7]	
30	IOH	I	P0[5]	
31	IOH	I	P0[3]	Integrating Input
32	Power		V _{SS}	Ground Pin ^[31]

LEGEND A = Analog, I = Input, O = Output, OH = 5 mA High Output Drive, R = Regulated Output.

Notes

27. 27 GPIOs = 22 pins for capacitive sensing + 2 pins for I2C + 2 pins for USB + 1 pin for modulation capacitor.

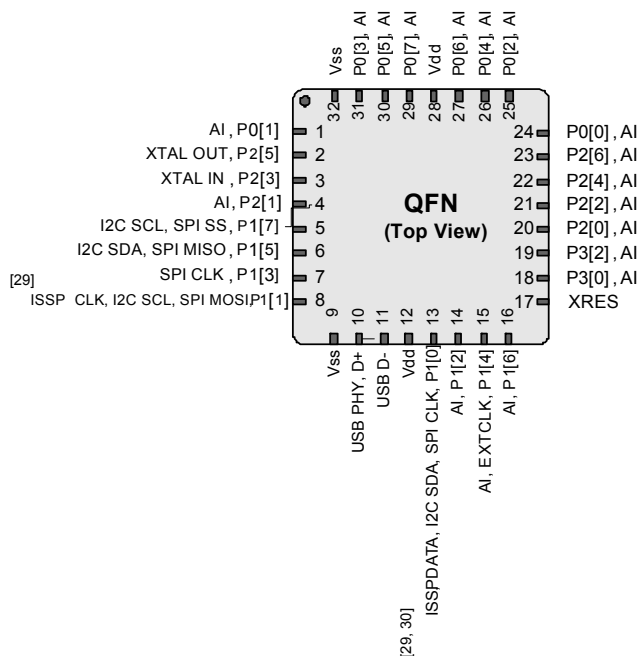
28. The center pad (CP) on the QFN package must be connected to ground (V_{SS}) for best mechanical, thermal, and electrical performance. If not connected to ground, it must be electrically floated and not connected to any other signal.

29. On power-up, the SDA(P1[0]) drives a strong high for 256 sleep clock cycles and drives resistive low for the next 256 sleep clock cycles. The SCL(P1[1]) line drives resistive low for 512 sleep clock cycles and both the pins transition to high impedance state. On reset, after XRES de-asserts, the SDA and the SCL lines drive resistive low for 8 sleep clock cycles and transition to high impedance state. Hence, during power-up or reset event, P1[1] and P1[0] may disturb the I2C bus. Use alternate pins if you encounter issues.

30. Alternate SPI clock.

31. All VSS pins should be brought out to one common GND plane.

Figure 8. CY8C20496A

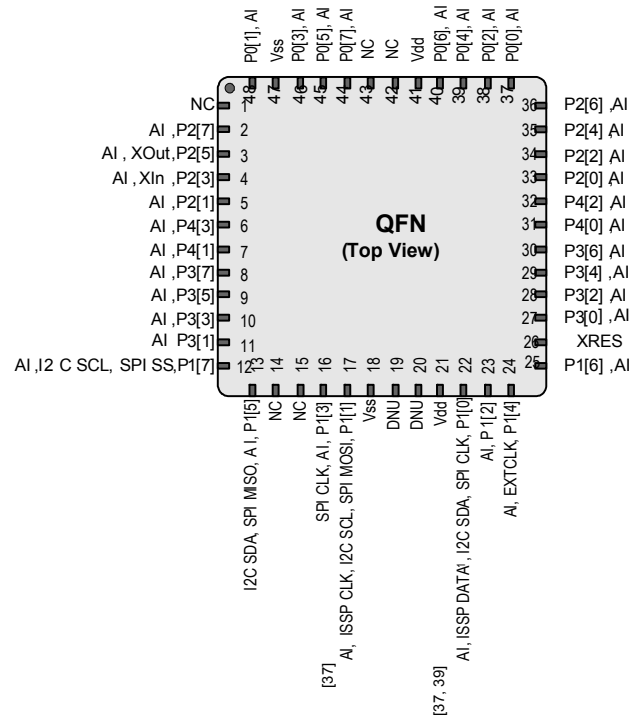


48-pin QFN (33 Sensing Inputs) [36]

Table 8. Pin Definitions – CY8C20636A [37, 38]

Pin No.	Digital	Analog	Name	Description
1			NC	No connection
2	I/O	I	P2[7]	
3	I/O	I	P2[5]	Crystal output (XOut)
4	I/O	I	P2[3]	Crystal input (XIn)
5	I/O	I	P2[1]	
6	I/O	I	P4[3]	
7	I/O	I	P4[1]	
8	I/O	I	P3[7]	
9	I/O	I	P3[5]	
10	I/O	I	P3[3]	
11	I/O	I	P3[1]	
12	IOHR	I	P1[7]	I ² C SCL, SPI SS
13	IOHR	I	P1[5]	I ² C SDA, SPI MISO
14			NC	No connection
15			NC	No connection
16	IOHR	I	P1[3]	SPI CLK
17	IOHR	I	P1[1]	ISSP CLK ^[37] , I ² C SCL, SPI MOSI
18	Power		V _{SS}	Ground connection ^[40]
19			DNU	
20			DNU	
21	Power		V _{DD}	Supply voltage
22	IOHR	I	P1[0]	ISSP DATA ^[37] , I ² C SDA, SPI CLK ^[39]
23	IOHR	I	P1[2]	
24	IOHR	I	P1[4]	Optional external clock input (EXTCLK)
25	IOHR	I	P1[6]	
26	Input		XRES	Active high external reset with internal pull-down
27	I/O	I	P3[0]	
28	I/O	I	P3[2]	
29	I/O	I	P3[4]	
30	I/O	I	P3[6]	
31	I/O	I	P4[0]	
32	I/O	I	P4[2]	
33	I/O	I	P2[0]	
34	I/O	I	P2[2]	
35	I/O	I	P2[4]	
36	I/O	I	P2[6]	
37	IOH	I	P0[0]	
38	IOH	I	P0[2]	
39	IOH	I	P0[4]	

Figure 10. CY8C20636A



Pin No.	Digital	Analog	Name	Description
40	IOH	I	P0[6]	
41	Power		V _{DD}	Supply voltage
42			NC	No connection
43			NC	No connection
44	IOH	I	P0[7]	
45	IOH	I	P0[5]	
46	IOH	I	P0[3]	Integrating input
47	Power		V _{SS}	Ground connection ^[40]
48	IOH	I	P0[1]	
CP	Power		V _{SS}	Center pad must be connected to ground

LEGEND A = Analog, I = Input, O = Output, NC = No Connection H = 5 mA High Output Drive, R = Regulated Output.

Notes

36. 36 GPIOs = 33 pins for capacitive sensing + 2 pins for I2C + 1 pin for modulation capacitor.
37. On power-up, the SDA(P1[0]) drives a strong high for 256 sleep clock cycles and drives resistive low for the next 256 sleep clock cycles. The SCL(P1[1]) line drives resistive low for 512 sleep clock cycles and both the pins transition to high impedance state. On reset, after XRES de-asserts, the SDA and the SCL lines drive resistive low for 8 sleep clock cycles and transition to high impedance state. Hence, during power-up or reset event, P1[1] and P1[0] may disturb the I2C bus. Use alternate pins if you encounter issues.
38. The center pad (CP) on the QFN package must be connected to ground (V_{SS}) for best mechanical, thermal, and electrical performance. If not connected to ground, it must be electrically floated and not connected to any other signal.
39. Alternate SPI clock.
40. All VSS pins should be brought out to one common GND plane.

48-pin QFN (OCD) (33 Sensing Inputs) ^[46]

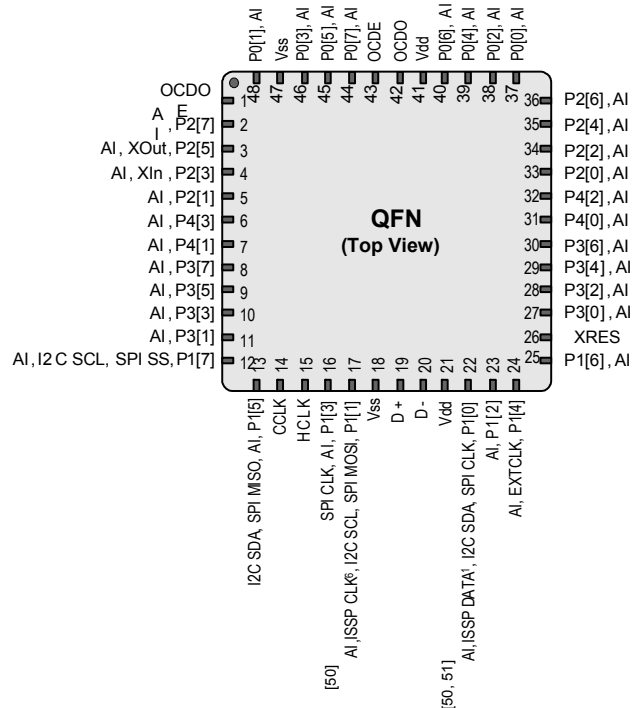
The 48-pin QFN part is for the CY8C20066A On-Chip Debug (OCD). Note that this part is only used for in-circuit debugging.

Table 10. Pin Definitions – CY8C20066A ^[47, 48]

Pin No.	Digital	Analog	Name	Description	Pin No.	Digital	Analog	Name	Description
1 ^[49]			OCDOE	OCD mode direction pin	37	IOH	I	P0[0]	
2	I/O	I	P2[7]		38	IOH	I	P0[2]	
3	I/O	I	P2[5]	Crystal output (XOut)	39	IOH	I	P0[4]	
4	I/O	I	P2[3]	Crystal input (XIn)	40	IOH	I	P0[6]	
5	I/O	I	P2[1]		41		Power	V _{DD}	Supply voltage
6	I/O	I	P4[3]		42 ^[49]			OCDO	OCD even data I/O
7	I/O	I	P4[1]		43 ^[49]			OCDE	OCD odd data output
8	I/O	I	P3[7]		44	IOH	I	P0[7]	
9	I/O	I	P3[5]		45	IOH	I	P0[5]	
10	I/O	I	P3[3]		46	IOH	I	P0[3]	Integrating input
11	I/O	I	P3[1]		47		Power	V _{SS}	Ground connection ^[52]
12	IOHR	I	P1[7]	I ² C SCL, SPI SS	48	IOH	I	P0[1]	
13	IOHR	I	P1[5]	I ² C SDA, SPI MISO	CP		Power	V _{SS}	Center pad must be connected to ground
14 ^[49]			CCLK	OCD CPU clock output					
15 ^[49]			HCLK	OCD high speed clock output					
16	IOHR	I	P1[3]	SPI CLK.					
17	IOHR	I	P1[1]	ISSP CLK ^[50] , I ² C SCL, SPI MOSI					
18		Power	V _{SS}	Ground connection ^[52]					
19	I/O		D+	USB D+					
20	I/O		D-	USB D-					
21		Power	V _{DD}	Supply voltage					
22	IOHR	I	P1[0]	ISSP DATA ^[50] , I ² C SDA, SPI CLK ^[51]					
23	IOHR	I	P1[2]						
24	IOHR	I	P1[4]	Optional external clock input (EXTCLK)					
25	IOHR	I	P1[6]						
26		Input	XRES	Active high external reset with internal pull-down					
27	I/O	I	P3[0]						
28	I/O	I	P3[2]						
29	I/O	I	P3[4]						
30	I/O	I	P3[6]						
31	I/O	I	P4[0]						
32	I/O	I	P4[2]						
33	I/O	I	P2[0]						
34	I/O	I	P2[2]						
35	I/O	I	P2[4]						
36	I/O	I	P2[6]						

LEGEND A = Analog, I = Input, O = Output, NC = No Connection H = 5 mA High Output Drive, R = Regulated Output.

Figure 12. CY8C20066A



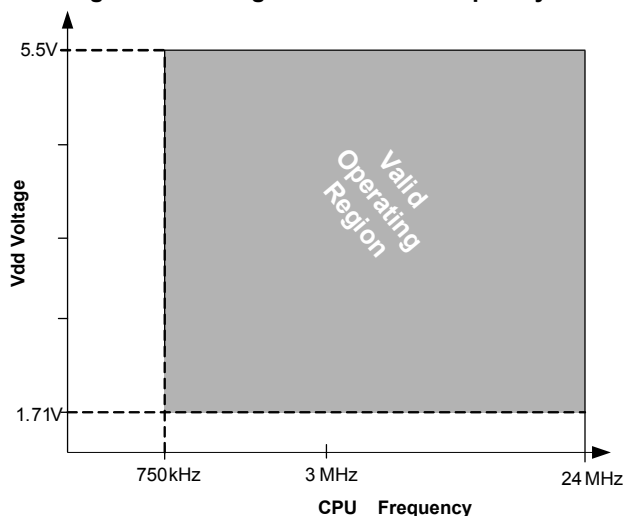
Notes

46. 38 GPIOs = 33 pins for capacitive sensing + 2 pins for I2C + 2 pins for USB + 1 pin for modulation capacitor.
47. This part is available in limited quantities for In-Circuit Debugging during prototype development. It is not available in production volumes.
48. The center pad (CP) on the QFN package must be connected to ground (V_{SS}) for best mechanical, thermal, and electrical performance. If not connected to ground, it must be electrically floated and not connected to any other signal.
49. This pin (associated with OCD part only) is required for connecting the device to ICE-Cube In-Circuit Emulator for firmware debugging purpose. To know more about the usage of ICE-Cube, refer to [CY3215-DK PSoC® IN-CIRCUIT EMULATOR KIT GUIDE](#).
50. On Power-up, the SDA(P1[0]) drives a strong high for 256 sleep clock cycles and drives resistive low for the next 256 sleep clock cycles. The SCL(P1[1]) line drives resistive low for 512 sleep clock cycles and both the pins transition to High impedance state. On reset, after XRES de-asserts, the SDA and the SCL lines drive resistive low for 8 sleep clock cycles and transition to high impedance state. In both cases, a pull-up resistance on these lines combines with the pull-down resistance (5.6K ohm) and form a potential divider. Hence, during power-up or reset event, P1[1] and P1[0] may disturb the I2C bus. Use alternate pins if you encounter issues.
51. Alternate SPI clock.
52. All VSS pins should be brought out to one common GND plane.

Electrical Specifications

This section presents the DC and AC electrical specifications of the CY8C20XX6A/S PSoC devices. For the latest electrical specifications, confirm that you have the most recent datasheet by visiting the web at <http://www.cypress.com/psoc>.

Figure 13. Voltage versus CPU Frequency



Absolute Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. User guidelines are not tested.

Table 11. Absolute Maximum Ratings

Symbol	Description	Conditions	Min	Typ	Max	Units
T_{STG}	Storage temperature	Higher storage temperatures reduce data retention time. Recommended Storage Temperature is $+25^{\circ}\text{C} \pm 25^{\circ}\text{C}$. Extended duration storage temperatures above 85°C degrades reliability.	-55	+25	+125	$^{\circ}\text{C}$
V_{DD}	Supply voltage relative to V_{SS}	—	-0.5	—	+6.0	V
V_{IO}	DC input voltage	—	$V_{SS} - 0.5$	—	$V_{DD} + 0.5$	V
$V_{IOZ}^{[53]}$	DC voltage applied to tristate	—	$V_{SS} - 0.5$	—	$V_{DD} + 0.5$	V
I_{MIO}	Maximum current into any port pin	—	-25	—	+50	mA
ESD	Electrostatic discharge voltage	Human body model ESD	2000	—	—	V
LU	Latch-up current	In accordance with JESD78 standard	—	—	200	mA

Operating Temperature

Table 12. Operating Temperature

Symbol	Description	Conditions	Min	Typ	Max	Units
T_A	Ambient temperature	—	-40	—	+85	$^{\circ}\text{C}$
T_C	Commercial temperature range	—	0	—	70	$^{\circ}\text{C}$
T_J	Operational die temperature	The temperature rise from ambient to junction is package specific. Refer the Thermal Impedances on page 38 . The user must limit the power consumption to comply with this requirement.	-40	—	+100	$^{\circ}\text{C}$

Note

53. Port1 pins are hot-swap capable with I/O configured in High-Z mode, and pin input voltage above V_{DD} .

DC GPIO Specifications

The following tables list guaranteed maximum and minimum specifications for the voltage and temperature ranges: 3.0 V to 5.5 V and $-40\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$, 2.4 V to 3.0 V and $-40\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$, or 1.71 V to 2.4 V and $-40\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$, respectively. Typical parameters apply to 5 V and 3.3 V at 25 °C and are for design guidance only.

Table 14. 3.0 V to 5.5 V DC GPIO Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
R _{PU}	Pull-up resistor	–	4	5.60	8	kΩ
V _{OH1}	High output voltage Port 2 or 3 or 4 pins	I _{OH} ≤ 10 μA, maximum of 10 mA source current in all I/Os	V _{DD} – 0.20	–	–	V
V _{OH2}	High output voltage Port 2 or 3 or 4 pins	I _{OH} = 1 mA, maximum of 20 mA source current in all I/Os	V _{DD} – 0.90	–	–	V
V _{OH3}	High output voltage Port 0 or 1 pins with LDO regulator Disabled for port 1	I _{OH} < 10 μA, maximum of 10 mA source current in all I/Os	V _{DD} – 0.20	–	–	V
V _{OH4}	High output voltage Port 0 or 1 pins with LDO regulator Disabled for port 1	I _{OH} = 5 mA, maximum of 20 mA source current in all I/Os	V _{DD} – 0.90	–	–	V
V _{OH5}	High output voltage Port 1 Pins with LDO Regulator Enabled for 3 V out	I _{OH} < 10 μA, V _{DD} > 3.1 V, maximum of 4 I/Os all sourcing 5 mA	2.85	3.00	3.30	V
V _{OH6}	High output voltage Port 1 pins with LDO regulator enabled for 3 V out	I _{OH} = 5 mA, V _{DD} > 3.1 V, maximum of 20 mA source current in all I/Os	2.20	–	–	V
V _{OH7}	High output voltage Port 1 pins with LDO enabled for 2.5 V out	I _{OH} < 10 μA, V _{DD} > 2.7 V, maximum of 20 mA source current in all I/Os	2.35	2.50	2.75	V
V _{OH8}	High output voltage Port 1 pins with LDO enabled for 2.5 V out	I _{OH} = 2 mA, V _{DD} > 2.7 V, maximum of 20 mA source current in all I/Os	1.90	–	–	V
V _{OH9}	High output voltage Port 1 pins with LDO enabled for 1.8 V out	I _{OH} < 10 μA, V _{DD} > 2.7 V, maximum of 20 mA source current in all I/Os	1.60	1.80	2.10	V
V _{OH10}	High output voltage Port 1 pins with LDO enabled for 1.8 V out	I _{OH} = 1 mA, V _{DD} > 2.7 V, maximum of 20 mA source current in all I/Os	1.20	–	–	V
V _{OL}	Low output voltage	I _{OL} = 25 mA, V _{DD} > 3.3 V, maximum of 60 mA sink current on even port pins (for example, P0[2] and P1[4]) and 60 mA sink current on odd port pins (for example, P0[3] and P1[5])	–	–	0.75	V
V _{IL}	Input low voltage	–	–	–	0.80	V
V _{IH}	Input high voltage	–	2.00	–	–	V
V _H	Input hysteresis voltage	–	–	80	–	mV
I _{IL}	Input leakage (Absolute Value)	–	–	0.001	1	μA
C _{PIN}	Pin capacitance	Package and pin dependent Temp = 25 °C	0.50	1.70	7	pF
V _{ILLVT3.3}	Input Low Voltage with low threshold enable set, Enable for Port1	Bit3 of IO_CFG1 set to enable low threshold voltage of Port1 input	0.8	V	–	–
V _{IHLVT3.3}	Input High Voltage with low threshold enable set, Enable for Port1	Bit3 of IO_CFG1 set to enable low threshold voltage of Port1 input	1.4	–	–	V
V _{ILLVT5.5}	Input Low Voltage with low threshold enable set, Enable for Port1	Bit3 of IO_CFG1 set to enable low threshold voltage of Port1 input	0.8	V	–	–
V _{IHLVT5.5}	Input High Voltage with low threshold enable set, Enable for Port1	Bit3 of IO_CFG1 set to enable low threshold voltage of Port1 input	1.7	–	–	V

Table 16. 1.71 V to 2.4 V DC GPIO Specifications (continued)

Symbol	Description	Conditions	Min	Typ	Max	Units
V _{IH}	Input high voltage	–	0.65 × V _{DD}	–	–	V
V _H	Input hysteresis voltage	–	–	80	–	mV
I _{IL}	Input leakage (absolute value)	–	–	1	1000	nA
C _{PIN}	Capacitive load on pins	Package and pin dependent temp = 25 °C	0.50	1.70	7	pF

Table 17. DC Characteristics – USB Interface

Symbol	Description	Conditions	Min	Typ	Max	Units
R _{USBI}	USB D+ pull-up resistance	With idle bus	900	–	1575	Ω
R _{USBA}	USB D+ pull-up resistance	While receiving traffic	1425	–	3090	Ω
V _{OHUSB}	Static output high	–	2.8	–	3.6	V
V _{OLUSB}	Static output low	–	–	–	0.3	V
V _{DI}	Differential input sensitivity	–	0.2	–	–	V
V _{CM}	Differential input common mode range	–	0.8	–	2.5	V
V _{SE}	Single ended receiver threshold	–	0.8	–	2.0	V
C _{IN}	Transceiver capacitance	–	–	–	50	pF
I _{IO}	High Z state data line leakage	On D+ or D- line	–10	–	+10	μA
R _{PS2}	PS/2 pull-up resistance	–	3000	5000	7000	Ω
R _{EXT}	External USB series resistor	In series with each USB pin	21.78	22.0	22.22	Ω

DC Analog Mux Bus Specifications

Table 18 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 18. DC Analog Mux Bus Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
R _{SW}	Switch resistance to common analog bus	–	–	–	800	Ω
R _{GND}	Resistance of initialization switch to V _{SS}	–	–	–	800	Ω

The maximum pin voltage for measuring R_{SW} and R_{GND} is 1.8 V

DC Low Power Comparator Specifications

Table 19 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 19. DC Comparator Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
V _{LPC}	Low power comparator (LPC) common mode	Maximum voltage limited to V _{DD}	0.0	–	1.8	V
I _{LPC}	LPC supply current	–	–	10	40	μA
V _{OSLPC}	LPC voltage offset	–	–	3	30	mV

AC Chip-Level Specifications

Table 27 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 27. AC Chip-Level Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
F _{IMO24}	IMO frequency at 24 MHz Setting	–	22.8	24	25.2	MHz
F _{IMO12}	IMO frequency at 12 MHz setting	–	11.4	12	12.6	MHz
F _{IMO6}	IMO frequency at 6 MHz setting	–	5.7	6.0	6.3	MHz
F _{CPU}	CPU frequency	–	0.75	–	25.20	MHz
F _{32K1}	ILO frequency	–	15	32	50	kHz
F _{32K_U}	ILO untrimmed frequency	–	13	32	82	kHz
DC _{IMO}	Duty cycle of IMO	–	40	50	60	%
DC _{ILO}	ILO duty cycle	–	40	50	60	%
SR _{POWER_UP}	Power supply slew rate	V _{DD} slew rate during power-up	–	–	250	V/ms
t _{XRST}	External reset pulse width at power-up	After supply voltage is valid	1	–	–	ms
t _{XRST2}	External reset pulse width after power-up ^[68]	Applies after part has booted	10	–	–	μs
t _{OS}	Startup time of ECO	–	–	1	–	s
t _{JIT_IMO} ^[69]	N=32	6 MHz IMO cycle-to-cycle jitter (RMS)	–	0.7	6.7	ns
		6 MHz IMO long term N (N = 32) cycle-to-cycle jitter (RMS)	–	4.3	29.3	ns
		6 MHz IMO period jitter (RMS)	–	0.7	3.3	ns
		12 MHz IMO cycle-to-cycle jitter (RMS)	–	0.5	5.2	ns
		12 MHz IMO long term N (N = 32) cycle-to-cycle jitter (RMS)	–	2.3	5.6	ns
		12 MHz IMO period jitter (RMS)	–	0.4	2.6	ns
		24 MHz IMO cycle-to-cycle jitter (RMS)	–	1.0	8.7	ns
		24 MHz IMO long term N (N = 32) cycle-to-cycle jitter (RMS)	–	1.4	6.0	ns
		24 MHz IMO period jitter (RMS)	–	0.6	4.0	ns

Notes

68. The minimum required XRES pulse length is longer when programming the device (see Table 33 on page 31).

69. Refer to Cypress Jitter Specifications application note, [Understanding Datasheet Jitter Specifications for Cypress Timing Products – AN5054](#) for more information.

AC Programming Specifications

Figure 15. AC Waveform

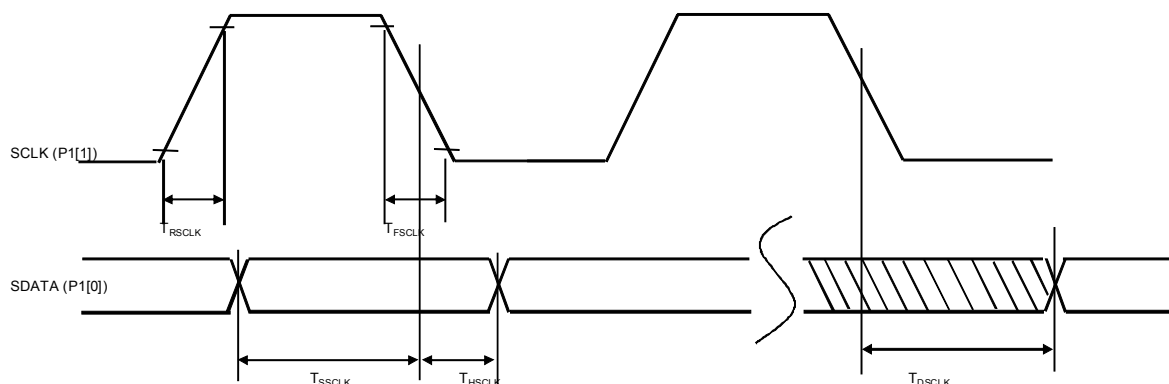


Table 33 lists the guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 33. AC Programming Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
t_{RSCLK}	Rise time of SCLK	—	1	—	20	ns
t_{FSCLK}	Fall time of SCLK	—	1	—	20	ns
t_{SSCLK}	Data setup time to falling edge of SCLK	—	40	—	—	ns
t_{HSCLK}	Data hold time from falling edge of SCLK	—	40	—	—	ns
F_{SCLK}	Frequency of SCLK	—	0	—	8	MHz
t_{ERASEB}	Flash erase time (block)	—	—	—	18	ms
t_{WRITE}	Flash block write time	—	—	—	25	ms
t_{DSCLK}	Data out delay from falling edge of SCLK	$3.6 < V_{DD}$	—	—	60	ns
t_{DSCLK3}	Data out delay from falling edge of SCLK	$3.0 \leq V_{DD} \leq 3.6$	—	—	85	ns
t_{DSCLK2}	Data out delay from falling edge of SCLK	$1.71 \leq V_{DD} \leq 3.0$	—	—	130	ns
t_{XRST3}	External reset pulse width after power-up	Required to enter programming mode when coming out of sleep	300	—	—	μ s
t_{XRES}	XRES pulse length	—	300	—	—	μ s
$t_{VDDWAIT}^{[71]}$	V_{DD} stable to wait-and-poll hold off	—	0.1	—	1	ms
$t_{VDDXRES}^{[71]}$	V_{DD} stable to XRES assertion delay	—	14.27	—	—	ms
t_{POLL}	SDATA high pulse time	—	0.01	—	200	ms
$t_{ACQ}^{[71]}$	"Key window" time after a V_{DD} ramp acquire event, based on 256 ILO clocks.	—	3.20	—	19.60	ms
$t_{XRESINI}^{[71]}$	"Key window" time after an XRES event, based on 8 ILO clocks	—	98	—	615	μ s

Note

71. Valid from 5 to 50 °C. See the spec, CY8C20X66, CY8C20X46, CY8C20X36, CY7C643XX, CY7C604XX, CY8CTST2XX, CY8CTMG2XX, CY8C20X67, CY8C20X47, CY8C20X37, Programming Spec for more details.

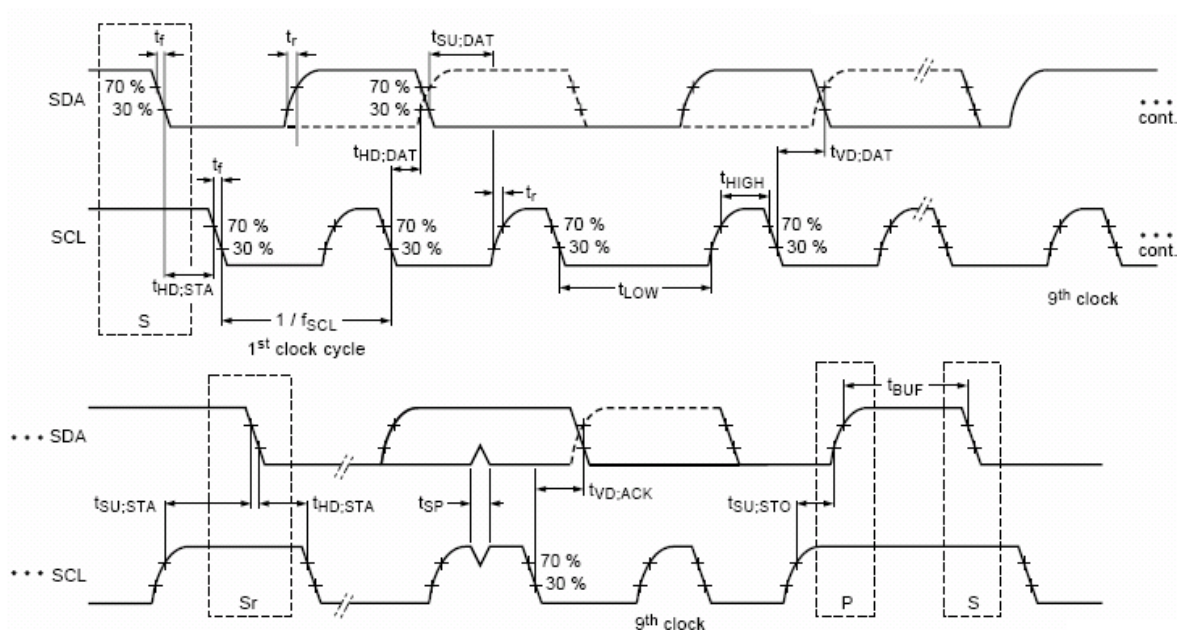
AC I²C Specifications

Table 34 lists guaranteed maximum and minimum specifications for the entire voltage and temperature ranges.

Table 34. AC Characteristics of the I²C SDA and SCL Pins

Symbol	Description	Standard Mode		Fast Mode		Units
		Min	Max	Min	Max	
f _{SCL}	SCL clock frequency	0	100	0	400	kHz
t _{HD;STA}	Hold time (repeated) START condition. After this period, the first clock pulse is generated	4.0	–	0.6	–	μs
t _{LOW}	LOW period of the SCL clock	4.7	–	1.3	–	μs
t _{HIGH}	HIGH Period of the SCL clock	4.0	–	0.6	–	μs
t _{SU;STA}	Setup time for a repeated START condition	4.7	–	0.6	–	μs
t _{HD;DAT}	Data hold time	0	3.45	0	0.90	μs
t _{SU;DAT}	Data setup time	250	–	100 ^[72]	–	ns
t _{SU;STO}	Setup time for STOP condition	4.0	–	0.6	–	μs
t _{BUF}	Bus free time between a STOP and START condition	4.7	–	1.3	–	μs
t _{SP}	Pulse width of spikes are suppressed by the input filter	–	–	0	50	ns

Figure 16. Definition for Timing for Fast/Standard Mode on the I²C Bus



Note

72. A Fast-Mode I²C-bus device can be used in a standard mode I²C-bus system, but the requirement t_{SU;DAT} ≥ 250 ns must then be met. This automatically be the case if the device does not stretch the LOW period of the SCL signal. If such device does stretch the LOW period of the SCL signal, it must output the next data bit to the SDA line t_{rmax} + t_{SU;DAT} = 1000 + 250 = 1250 ns (according to the Standard-Mode I²C-bus specification) before the SCL line is released.

Table 35. SPI Master AC Specifications

Symbol	Description	Conditions	Min	Typ	Max	Units
F_{SCLK}	SCLK clock frequency	$V_{DD} \geq 2.4 \text{ V}$ $V_{DD} < 2.4 \text{ V}$	— —	— —	6 3	MHz MHz
DC	SCLK duty cycle	—	—	50	—	%
t_{SETUP}	MISO to SCLK setup time	$V_{DD} \geq 2.4 \text{ V}$ $V_{DD} < 2.4 \text{ V}$	60 100	— —	— —	ns ns
t_{HOLD}	SCLK to MISO hold time	—	40	—	—	ns
t_{OUT_VAL}	SCLK to MOSI valid time	—	—	—	40	ns
t_{OUT_H}	MOSI high time	—	40	—	—	ns

Figure 17. SPI Master Mode 0 and 2

SPI Master, modes 0 and 2

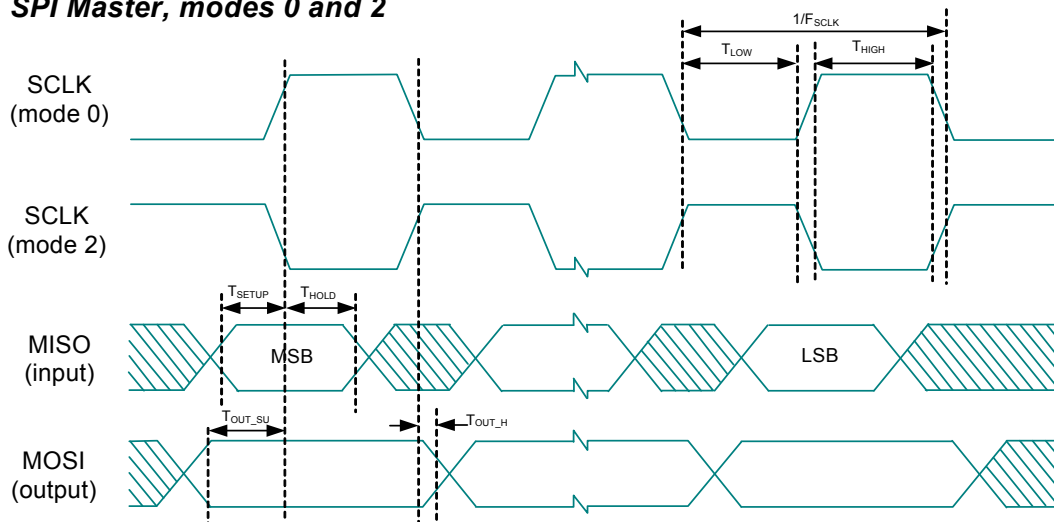
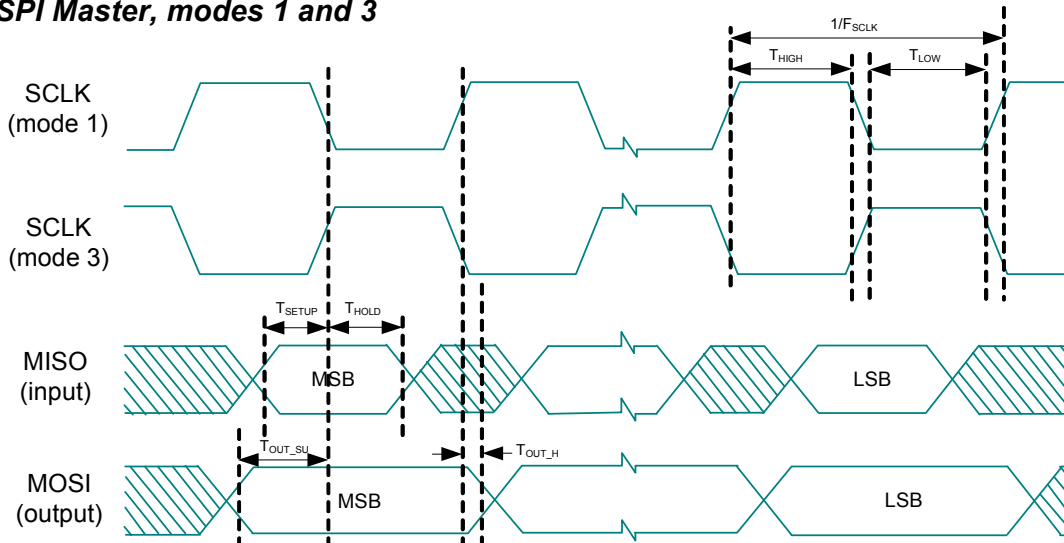


Figure 18. SPI Master Mode 1 and 3

SPI Master, modes 1 and 3



CY3207ISSP In-System Serial Programmer (ISSP)

The CY3207ISSP is a production programmer. It includes protection circuitry and an industrial case that is more robust than the MiniProg in a production programming environment.

Note that CY3207ISSP needs special software and is not compatible with PSoC Programmer. The kit includes:

- CY3207 Programmer Unit
- PSoC ISSP Software CD
- 110 ~ 240 V Power Supply, Euro-Plug Adapter
- USB 2.0 Cable

Accessories (Emulation and Programming)

Table 40. Emulation and Programming Accessories

Part Number	Pin Package	Flex-Pod Kit ^[75]	Foot Kit ^[76]	Adapter ^[77]
CY8C20236A-24LKXI	16-pin QFN (No E-Pad)	CY3250-20246QFN	CY3250-20246QFN-POD	See note 74
CY8C20246A-24LKXI	16-pin QFN (No E-Pad)	CY3250-20246QFN	CY3250-20246QFN-POD	See note 77
CY8C20246AS-24LKXI	16-pin QFN (No E-Pad)	Not Supported		
CY8C20336A-24LQXI	24-pin QFN	CY3250-20346QFN	CY3250-20346QFN-POD	See note 74
CY8C20346A-24LQXI	24-pin QFN	CY3250-20346QFN	CY3250-20346QFN-POD	See note 77
CY8C20346AS-24LQXI	24-pin QFN	Not Supported		
CY8C20396A-24LQXI	24-pin QFN	Not Supported		
CY8C20436A-24LQXI	32-pin QFN	CY3250-20466QFN	CY3250-20466QFN-POD	See note 74
CY8C20446A-24LQXI	32-pin QFN	CY3250-20466QFN	CY3250-20466QFN-POD	See note 77
CY8C20446AS-24LQXI	32-pin QFN	Not Supported		
CY8C20466A-24LQXI	32-pin QFN	CY3250-20466QFN	CY3250-20466QFN-POD	See note 77
CY8C20466AS-24LQXI	32-pin QFN	Not Supported		
CY8C20496A-24LQXI	32-pin QFN	Not Supported		
CY8C20536A-24PVXI	48-pin SSOP	CY3250-20566	CY3250-20566-POD	See note 77
CY8C20546A-24PVXI	48-pin SSOP	CY3250-20566	CY3250-20566-POD	See note 77
CY8C20566A-24PVXI	48-pin SSOP	CY3250-20566	CY3250-20566-POD	See note 77

Third Party Tools

Several tools have been specially designed by third-party vendors to accompany PSoC devices during development and production. Specific details for each of these tools can be found at <http://www.cypress.com> under Documentation > Evaluation Boards.

Build a PSoC Emulator into Your Board

For details on how to emulate your circuit before going to volume production using an on-chip debug (OCD) non-production PSoC device, refer Application Note [Debugging - Build a PSoC Emulator into Your Board – AN2323](#).

Notes

75. Flex-Pod kit includes a practice flex-pod and a practice PCB, in addition to two flex-pods.

76. Foot kit includes surface mount feet that can be soldered to the target PCB.

77. Programming adapter converts non-DIP package to DIP footprint. Specific details and ordering information for each of the adapters can be found at <http://www.emulation.com>.

Table 41. PSoC Device Key Features and Ordering Information (continued)

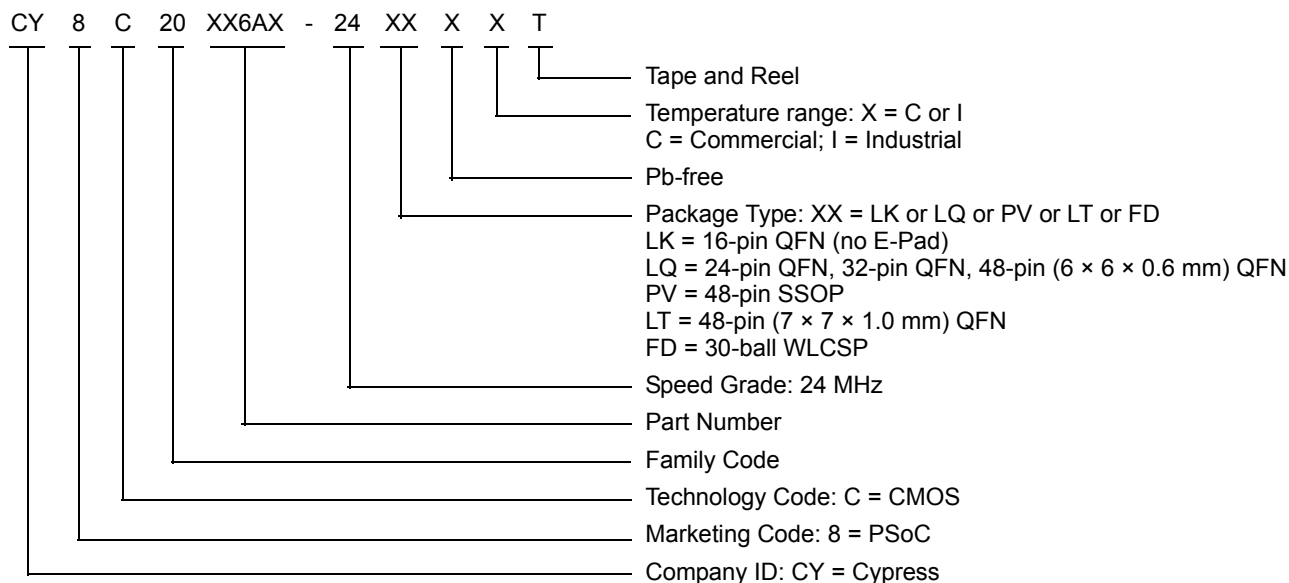
Package	Ordering Code	Flash (Bytes)	SRAM (Bytes)	CapSense Blocks	Digital I/O Pins	Analog Inputs ^[78]	XRES Pin	USB	ADC
24-pin (4 × 4 × 0.6 mm) QFN	CY8C20346AS-24LQXI	16 K	2 K	1	20	20	Yes	No	Yes
24-pin (4 × 4 × 0.6 mm) QFN (Tape and Reel)	CY8C20346AS-24LQXIT	16 K	2 K	1	20	20	Yes	No	Yes
32-pin (5 × 5 × 0.6 mm) QFN	CY8C20446AS-24LQXI	16 K	2 K	1	28	28	Yes	No	Yes
32-pin (5 × 5 × 0.6 mm) QFN (Tape and Reel)	CY8C20446AS-24LQXIT	16 K	2 K	1	28	28	Yes	No	Yes
32-pin (5 × 5 × 0.6 mm) QFN	CY8C20466AS-24LQXI	32 K	2 K	1	28	28	Yes	No	Yes
32-pin (5 × 5 × 0.6 mm) QFN (Tape and Reel)	CY8C20466AS-24LQXIT	32 K	2 K	1	28	28	Yes	No	Yes
48-pin (6 × 6 × 0.6 mm) QFN	CY8C20666AS-24LQXI	32 K	2 K	1	36	36	Yes	Yes	Yes
48-pin (6 × 6 × 0.6 mm) QFN (Tape and Reel)	CY8C20666AS-24LQXIT	32 K	2 K	1	36	36	Yes	Yes	Yes
48-pin (7 × 7 × 1.0 mm) QFN ^[79]	CY8C20666AS-24LTXI ^[79]	32 K	2 K	1	36	36	Yes	Yes	Yes
48-pin (7 × 7 × 1.0 mm) QFN (Tape and Reel) ^[79]	CY8C20666AS-24LTXIT ^[79]	32 K	2 K	1	36	36	Yes	Yes	Yes
48-pin (6 × 6 × 0.6 mm) QFN	CY8C20646AS-24LQXI	16 K	2 K	1	36	36	Yes	Yes	Yes
48-pin (6 × 6 × 0.6 mm) QFN (Tape and Reel)	CY8C20646AS-24LQXIT	16 K	2 K	1	36	36	Yes	Yes	Yes
48-pin (7 × 7 × 1.0 mm) QFN ^[79]	CY8C20646AS-24LTXI ^[79]	16 K	2 K	1	36	36	Yes	Yes	Yes
48-pin (7 × 7 × 1.0 mm) QFN (Tape and Reel) ^[79]	CY8C20646AS-24LTXIT ^[79]	16 K	2 K	1	36	36	Yes	Yes	Yes

Notes

78. Dual-function Digital I/O Pins also connect to the common analog mux.

79. Not Recommended for New Designs.

Ordering Code Definitions



Acronyms

Table 42. Acronyms Used in this Document

Acronym	Description
AC	alternating current
ADC	analog-to-digital converter
API	application programming interface
CMOS	complementary metal oxide semiconductor
CPU	central processing unit
DAC	digital-to-analog converter
DC	direct current
EOP	end of packet
FSR	full scale range
GPIO	general purpose input/output
GUI	graphical user interface
I ² C	inter-integrated circuit
ICE	in-circuit emulator
IDAC	digital analog converter current
ILO	internal low speed oscillator
IMO	internal main oscillator
I/O	input/output
ISSP	in-system serial programming
LCD	liquid crystal display
LDO	low dropout (regulator)
LSB	least-significant bit
LVD	low voltage detect
MCU	micro-controller unit
MIPS	mega instructions per second
MISO	master in slave out
MOSI	master out slave in
MSB	most-significant bit
OCD	on-chip debugger
POR	power on reset
PPOR	precision power on reset
PSRR	power supply rejection ratio
PWRSYS	power system
PSoC®	Programmable System-on-Chip
SLIMO	slow internal main oscillator
SRAM	static random access memory
SNR	signal to noise ratio
QFN	quad flat no-lead
SCL	serial I2C clock
SDA	serial I2C data
SDATA	serial ISSP data
SPI	serial peripheral interface
SS	slave select
SSOP	shrink small outline package
TC	test controller
USB	universal serial bus
USB D+	USB Data+
USB D-	USB Data-
WLCSP	wafer level chip scale package
XTAL	crystal

Reference Documents

- *Technical Reference Manual for CY8C20xx6 devices*
- *In-system Serial Programming (ISSP) protocol for 20xx6 (AN2026C)*
- *Host Sourced Serial Programming for 20xx6 devices (AN59389)*

Document Conventions

Units of Measure

Table 43. Units of Measure

Symbol	Unit of Measure
°C	degree Celsius
dB	decibels
fF	femtofarad
g	gram
Hz	hertz
KB	1024 bytes
Kbit	1024 bits
KHz	kilohertz
Ksps	kilo samples per second
kΩ	kilohm
MHz	megahertz
MΩ	megaohm
μA	microampere
μF	microfarad
μH	microhenry
μs	microsecond
μW	microwatt
mA	milliampere
ms	millisecond
mV	millivolt
nA	nanoampere
nF	nanofarad
ns	nanosecond
nV	nanovolt
W	ohm
pA	picoampere
pF	picofarad
pp	peak-to-peak
ppm	parts per million
ps	picosecond
sps	samples per second
s	sigma: one standard deviation
V	volt
W	watt

5. Missed Interrupt During Transition to Sleep

■ **Problem Definition**

If an interrupt is posted a short time (within 2.5 CPU cycles) before firmware commands the device to sleep, the interrupt will be missed.

■ **Parameters Affected**

No datasheet parameters are affected.

■ **Trigger Condition(S)**

Triggered by enabling sleep mode just prior to an interrupt.

■ **Scope of Impact**

The relevant interrupt service routine will not be run.

■ **Workaround**

None.

■ **Fix Status**

Will not be fixed

■ **Changes**

None

6. Wakeup from sleep with analog interrupt

■ **Problem Definition**

Device wakes up from sleep when an analog interrupt is trigger

■ **Parameters Affected**

No datasheet parameters are affected.

■ **Trigger Condition(S)**

Triggered by enabling analog interrupt during sleep mode when device operating temperature is 50 °C or above

■ **Scope of Impact**

Device unexpectedly wakes up from sleep

■ **Workaround**

Disable the analog interrupt before entering sleep and turn it back on upon wakeup.

■ **Fix Status**

Will not be fixed

■ **Changes**

None

Document History Page

Document Title: CY8C20XX6A/S, 1.8 V Programmable CapSense® Controller with SmartSense™ Auto-tuning 1–33 Buttons, 0–6 Sliders Document Number: 001-54459				
Revision	ECN	Orig. of Change	Submission Date	Description of Change
**	2737924	SNV	07/14/2009	New silicon and document
*A	2764528	MATT	09/16/2009	Updated AC Chip Level Specifications Updated ADC User Module Electrical Specifications table Added Note 5. Added SR _{POWER_UP} parameter. Updated Ordering information. Updated Capacitance on Crystal Pins
*B	2803229	VZD	11/10/2009	Added “ Contents ” on page 4. Added Note 6 on page 20. Edited Features section to include reference to Incremental ADC.
*C	2846083	DST / KEJO	01/12/2010	Updated “ AC Programming Specifications ” on page 31 per CDT 56531. Updated Idd typical values in “ DC Chip-Level Specifications ” on page 21. Added 30-pin WLCSP pin and package details. Added Contents on page 2.
*D	2935141	KEJO/ISW / SSHH	03/05/2010	Updated “ Features ” on page 1. Added “ SmartSense ” on page 5. Updated “ PSoC® Functional Overview ” on page 5. Removed SNR statement regarding on page 4 (Analog Multiplexer section). Updated Additional System Resources on page 6 with the I2C enhanced slave interface point. Removed references to “system level” in “ Designing with PSoC Designer ” on page 9. Changed TC CLK and TC DATA to ISSP CLK and ISSP DATA respectively in all the pinouts. Modified notes in Pinouts. Updated 30-ball pin diagram. Removed IMO frequency trim options diagram in “ Electrical Specifications ” on page 20. Updated and formatted values in DC and AC specifications. Updated Ordering information table. Updated 48-pin SSOP package diagram. Added 30-Ball WLCSP package spec 001-50669. Removed AC Analog Mux Bus Specifications section. Added SPI Master and Slave mode diagrams. Modified Definition for Timing for Fast/Standard Mode on the I2C Bus on page 28 . Updated “ Thermal Impedances ” on page 38. Combined Development Tools with “ Development Tool Selection ” on page 39. Removed references to “system level”. Updated “ Evaluation Tools ” on page 39. Added “ Ordering Code Definitions ” on page 43. Updated “ Acronyms ” on page 44. Added Glossary and “ Reference Documents ” on page 44. Changed datasheet status from Preliminary to Final
*E	3043291	SAAC	09/30/2010	Change: Added the line “Supports SmartSense” in the “Low power CapSense® block” bullet in the Features section. Impact: Helps to know that this part has the feature of Auto Tuning. Change: Replaced pod MPNs. Areas affected: Foot kit column of table 37. Change: Template and Styles update. Areas affected: Entire datasheet. Impact: Datasheet adheres to Cypress standards.
*F	3071632	JPX	10/26/2010	In Table 36 on page 34 , modified t _{LOW} and t _{HIGH} min values to 42. Updated t _{SS_HIGH} min value to 50; removed max value.

Document History Page (continued)

Document Title: CY8C20XX6A/S, 1.8 V Programmable CapSense® Controller with SmartSense™ Auto-tuning 1–33 Buttons, 0–6 Sliders Document Number: 001-54459				
Revision	ECN	Orig. of Change	Submission Date	Description of Change
*G	3247491	TTO / JPM / ARVM / BVI	06/16/2011	Add 4 new parameters to Table 14 on page 22 , and 2 new parameters to Table 15 on page 23 . Changed Typ values for the following parameters: I_{DD24} , I_{DD12} , I_{DD6} , V_{OSLPC} . Added footnote # 49 and referred it to pin numbers 1, 14, 15, 42, and 43 under Table 10 on page 19 . Added footnote # 53 and referred it to parameter V_{IOZ} under Table 11 on page 20 . Added “ t_{JIT_IMO} ” parameter to Table 27 on page 28 . Included footnote # 69 and added reference to t_{JIT_IMO} specification under Table 27 on page 28 . Updated Solder Reflow Specifications on page 38 as per specs 25-00090 and 25-00103. I_{SB0} Max value changed from 0.5 μA to 1.1 μA in Table 13 on page 21 . Added Table 26 on page 27 . Updated part numbers for “SmartSense_EMC” enabled CapSense controller.
*H	3367332	BTK / SSHH / JPM / TTO / VMAD	09/09/2011	Added parameter “ t_{OS} ” to Table 27 on page 28 . Added parameter “ I_{SBI2C} ” to Table 13 on page 21 . Added Table 24 on page 27 . Added Table 25 on page 27 . Replaced text “Port 2 or 3 pins” with “Port 2 or 3 or 4 pins” in Table 14 , Table 15 , Table 16 , and Table 28 .
*I	3371807	MATT	09/30/2011	Updated Packaging Information (Updated the next revision package outline for Figure 21 , Figure 24 and included a new package outline Figure 26). Updated Ordering Information (Added new part numbers CY8C20636A-24LQXI, CY8C20636A-24LQXIT, CY8C20646A-24LQXI, CY8C20646A-24LQXIT, CY8C20666A-24LQXI, CY8C20666A-24LQXIT, CY8C20666AS-24LQXI, CY8C20666AS-24LQXIT, CY8C20646AS-24LQXI and CY8C20646AS-24LQXIT). Updated to new template.
*J	3401666	MATT	10/11/2011	No technical updates.
*K	3414479	KPOL	10/19/2011	Removed clock stretching feature on page 1. Removed I ² C enhanced slave interface point from Additional System Resources .
*L	3452591	BVI / UDYG	12/01/2011	Changed document title. Updated DC Chip-Level Specifications table. Updated Solder Reflow Specifications section. Updated Getting Started and Designing with PSoC Designer sections. Included Development Tools section. Updated Software under Development Tool Selection section.
*M	3473330	ANBA	12/22/2011	Updated DC Chip-Level Specifications under Electrical Specifications (updated maximum value of I_{SB0} parameter from 1.1 μA to 1.05 μA).
*N	3587003	DST	04/16/2012	Added note for WLCSP package on page 1. Added Sensing inputs to pin table captions. Updated Conditions for DC Reference Buffer Specifications . Updated t_{JIT_IMO} description in AC Chip-Level Specifications . Added note for $t_{VDDWAIT}$, $t_{VDDXRES}$, t_{ACQ} , and $t_{XRESINI}$ specs. Removed WLCSP package outline.
*O	3638569	BVI	06/06/2012	Updated F_{SCLK} parameter in the Table 36 , “ SPI Slave AC Specifications ,” on page 34. Changed t_{OUT_HIGH} to t_{OUT_H} in Table 35 , “ SPI Master AC Specifications ,” on page 33. Updated package diagram 001-57280 to *C revision.